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				Application Number	10/578,140-Conf. #8843
				Filing Date	May 3, 2006
				First Named Inventor	Chang-Hae KIM
				Art Unit	4174
				Examiner Name	M. E. Bowman
Sheet	1	of	1	Attorney Docket Number	3449-0620PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	AA*	US-2004/0245532-A1	12-09-2004	Maeda et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T <sup>6</sup>
	BA**	JP-2001-143869-A	05-25-2001			ABS
	BB**	JP-2000-509912-A	08-02-2000			ABS
	BC**	JP-11-246857-A	09-14-1999			ABS
	BD**	JP-2000-183408-A	06-30-2000			ABS

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